

# N- and P-Channel 100 V (D-S) MOSFET

PRODUCT SUMMARY							
	V <sub>DS</sub> (V)	R <sub>DS(on)</sub> (Ω) MAX.	I <sub>D</sub> (A) <sup>a</sup>	Q <sub>g</sub> (TYP.)			
N-Channel	100	0.057 at V <sub>GS</sub> = 10 V	5.6	1			
		$0.072$ at $V_{GS} = 4.5 \text{ V}$	5	4			
P-Channel	-100	0.183 at V <sub>GS</sub> = -10 V	-3.4	11.6			
r-Chaine	-100	$0.205$ at $V_{GS} = -4.5 \text{ V}$	-3.2	11.0			

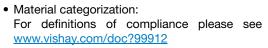


#### **Ordering Information:**

Si4590DY-T1-GE3 (Lead (Pb)-free and Halogen-free)

#### **FEATURES**

- TrenchFET® Power MOSFET
- 100 % R<sub>g</sub> and UIS tested

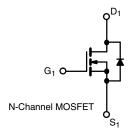


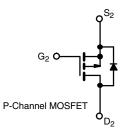


ROHS COMPLIANT HALOGEN FREE

#### **APPLICATIONS**

- H bridge / DC-AC inverter
  - Brushless DC motors





PARAMETER	SYMBOL	N-CHANNEL	P-CHANNEL	UNIT		
Drain-Source Voltage	V <sub>DS</sub>	100	-100	V		
Gate-Source Voltage	$V_{GS}$	±	V			
	T <sub>F</sub> = 25 °C		5.6	-3.4		
Continuous Duais Courset /T 150 °C	T <sub>F</sub> = 70 °C	] ,	4.5	-2.7		
Continuous Drain Current (T <sub>J</sub> = 150 °C)	T <sub>A</sub> = 25 °C	- I <sub>D</sub>	4.5 b,c	-2.5 b,c		
	T <sub>A</sub> = 70 °C		3.6 b,c	-2 b,c		
Pulsed Drain Current (100 µs Pulse Width)	I <sub>DM</sub>	30	-20	Α		
Source-Drain Current Diode Current	T <sub>F</sub> = 25 °C	- I <sub>S</sub>	3	-3.5		
Source-Drain Current Diode Current	T <sub>A</sub> = 25 °C		2 b,c	-1.9 <sup>b,c</sup>		
Pulsed Source-Drain Current (100 µs Pulse Wid	I <sub>SM</sub>	30	-20			
Single Pulse Avalanche Current	L = 0.1 mH	I <sub>AS</sub>	5	-20		
Single Pulse Avalanche Energy	L = 0.1 mH	E <sub>AS</sub>	1.3	20	mJ	
	T <sub>F</sub> = 25 °C		3.6	4.2		
Mayimum Dawar Dissination	T <sub>F</sub> = 70 °C	P <sub>D</sub>	2.3	2.7	W	
Maximum Power Dissipation	T <sub>A</sub> = 25 °C		2.3 b,c	2.3 b,c	VV	
	T <sub>A</sub> = 70 °C	1	1.5 b,c	1.5 <sup>b,c</sup>		
Operating Junction and Storage Temperature R	T <sub>J</sub> , T <sub>stg</sub>	-55 t	°C			

THERMAL RESISTANCE RATINGS								
PARAMETER	SYMBOL	N-CHANNEL		P-CHANNEL		UNIT		
PARAIVIETER		TYP.	MAX.	TYP.	MAX.	ONII		
Maximum Junction-to-Ambient <sup>b,d</sup> t ≤ 10 s		R <sub>thJA</sub>	35	55	33	55	°C/W	
Maximum Junction-to-Foot (Drain)	Steady State	R <sub>thJF</sub>	20	35	17	30	C/VV	

#### Notes

- a. Based on  $T_F = 25$  °C.
- b. Surface mounted on 1" x 1" FR4 board.
- c. t = 10 s
- d. Maximum under steady state conditions is 90 °C/W (n-channel) and 90 °C/W (p-channel).



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PARAMETER	SYMBOL	TEST CONDITIONS	MIN.		I. TYP.	MAX.	UNIT	
Static				L				
D : 0 D   1   W		$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	N-Ch	100	-	-	٧	
Drain-Source Breakdown Voltage	V <sub>DS</sub>	$V_{GS} = 0 \text{ V}, I_D = -250 \mu\text{A}$	P-Ch	-100	-	-		
V. Tananani a Osaffaisai		I <sub>D</sub> = 250 μA	N-Ch	-	70	-	mV/°C	
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	I <sub>D</sub> = -250 μA	P-Ch	-	-103	-		
V Temperature Coefficient	A)/ /T	I <sub>D</sub> = 250 μA	N-Ch	-	-5.7	-		
V <sub>GS(th)</sub> Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	I <sub>D</sub> = -250 μA	P-Ch	-	4.5	-		
Gate Threshold Voltage		$V_{DS} = V_{GS}, I_D = 250 \mu A$	N-Ch	1.5	-	2.5	V	
Gate Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}, I_D = -250 \mu A$	P-Ch	-1.5	-	-2.5		
Gate-Body Leakage	l	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$	N-Ch	-	-	100	nΛ	
Gale-Body Leakage	I <sub>GSS</sub>	$v_{DS} = 0  v,  v_{GS} = \pm 20  v$	P-Ch	-	-	-100	- nA	
		$V_{DS} = 100 \text{ V}, V_{GS} = 0 \text{ V}$	N-Ch	-	-	1		
Zoro Cata Valtaga Drain Current		V <sub>DS</sub> = -100 V, V <sub>GS</sub> = 0 V	P-Ch	-	-	-1	- μΑ	
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = 100 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 55 °C	N-Ch	-	-	10		
		V <sub>DS</sub> = -100 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 55 °C	P-Ch	-	-	-10		
On-State Drain Current <sup>b</sup>	I <sub>D(on)</sub>	V <sub>DS</sub> = 5 V, V <sub>GS</sub> = 10 V	N-Ch	10	-	-	А	
		$V_{DS} = -5 \text{ V}, V_{GS} = -10 \text{ V}$	P-Ch	-10	-	-		
	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 2 A	N-Ch	-	0.047	0.057		
Drain-Source On-State Resistance b		$V_{GS} = -10 \text{ V}, I_D = -2 \text{ A}$	P-Ch	-	0.150	0.183		
		$V_{GS} = 4.5 \text{ V}, I_D = 1.5 \text{ A}$	N-Ch	-	0.059	0.072	Ω	
		$V_{GS} = -4.5 \text{ V}, I_D = -1 \text{ A}$	P-Ch	-	0.165	0.205		
Farmered Transport and the base h		$V_{DS} = 15 \text{ V}, I_D = 2 \text{ A}$	N-Ch	-	9	-	s	
Forward Transconductance b	9 <sub>fs</sub>	V <sub>DS</sub> = -15 V, I <sub>D</sub> = -2 A	P-Ch	-	9.3	-		
Dynamic <sup>a</sup>					•	•		
Input Canacitance	C.		N-Ch	-	360	-	pF	
Input Capacitance	C <sub>iss</sub>	N-Channel	P-Ch	-	1150	-		
Output Capacitance	6	$V_{DS} = 50 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$	N-Ch	-	130	-		
Output Capacitance	C <sub>oss</sub>	P-Channel	P-Ch	-	65	-		
Deverage Transfer Conscitones		$V_{DS} = -50 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$	N-Ch	-	20	-		
Reverse Transfer Capacitance	$C_{rss}$		P-Ch	-	40	-		
		V <sub>DS</sub> = 50 V, V <sub>GS</sub> = 10 V, I <sub>D</sub> = 4.5 A	N-Ch	-	7.5	11.5	nC	
Tatal Cata Chausa		$V_{DS} = -50 \text{ V}, V_{GS} = -10 \text{ V}, I_D = -5 \text{ A}$	P-Ch	-	24	36		
Total Gate Charge	Qg		N-Ch	-	4	6		
		N-Channel	P-Ch	-	11.6	18		
Oak Oak and Oka and	$Q_{gs}$	$V_{DS} = 50 \text{ V}, V_{GS} = 4.5 \text{ V}, I_D = 4.5 \text{ A}$	N-Ch	-	1.2	-		
Gate-Source Charge		P-Channel	P-Ch	-	3.8	-		
Octo Ducio Chause		$V_{DS} = -50 \text{ V}, V_{GS} = -4.5 \text{ V}, I_D = -5 \text{ A}$	N-Ch	-	2	-		
Gate-Drain Charge	$Q_{gd}$		P-Ch	-	5	-		
0.1.5			N-Ch	0.6	3.3	6.6	_	
Gate Resistance	$R_g$	f = 1 MHz	P-Ch	3	13	26	Ω	



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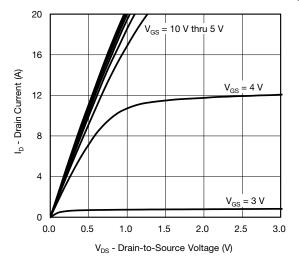
PARAMETER	SYMBOL TEST CONDITIONS				TYP.	MAX.	UNIT
Dynamic <sup>a</sup>	•					•	,
Turn-On Delay Time	† <sub>11</sub> .		N-Ch	-	5	10	
Turn On Belay Time	t <sub>d(on)</sub>	N-Channel	P-Ch	-	7	15	
Rise Time	t <sub>r</sub>	$V_{DD} = 50 \text{ V}, R_L = 13.8 \Omega$	N-Ch	-	11	20	
1100 11110		$I_D\cong 3.6$ A, $V_{GEN}=10$ V, $R_g=1$ $\Omega$	P-Ch	-	11	20	
Turn-Off Delay Time	t <sub>d(off)</sub>	P-Channel	N-Ch	-	12	25	
	u(on)	$V_{DD} = -50 \text{ V}, R_L = 12.5 \Omega$ $I_D \cong -4 \text{ A}, V_{GEN} = -10 \text{ V}, R_q = 1 \Omega$	P-Ch	-	65	130	
Fall Time	t <sub>f</sub>	.b =, .dEN,g	N-Ch	-	6	15	
			P-Ch	-	20	40	ns
Turn-On Delay Time	t <sub>d(on)</sub>		N-Ch	-	32	65	-
·	=(5.1)	N-Channel	P-Ch	=.	55	110	
Rise Time	t <sub>r</sub>	$V_{DD}$ = 50 V, $R_L$ = 13.8 $\Omega$ $I_D \cong$ 3.6 A, $V_{GEN}$ = 4.5 V, $R_q$ = 1 $\Omega$	N-Ch	-	73	150	
		-	P-Ch	-	80	160	
Turn-Off Delay Time	t <sub>d(off)</sub>	P-Channel $V_{DD} = -50 \text{ V}, R_L = 12.5 \Omega$	N-Ch P-Ch		14	30	
		$I_D \cong -4 \text{ A}, V_{GEN} = -4.5 \text{ V}, R_g = 1 \Omega$	N-Ch	-	42 12	85 25	
Fall Time	t <sub>f</sub>			-	25	50	-
Drain-Source Body Diode Characteristi	rs		P-Ch		20	30	
Drain Course Body Brode Orial deterrior	1		N-Ch	T -	l <u>-</u>	3	<u> </u>
Continuous Source-Drain Diode Current	I <sub>S</sub>	T <sub>F</sub> = 25 °C	P-Ch	-	-	-3.5	
			N-Ch	_	-	30	Α
Pulse Diode Forward Current <sup>a</sup>	I <sub>SM</sub>		P-Ch	-	-	-20	1
	V <sub>SD</sub>	I <sub>S</sub> = 3.6 A	N-Ch	-	0.83	1.2	
Body Diode Voltage		I <sub>S</sub> = -4 A	P-Ch	-	-0.8	-1.2	V
	t <sub>rr</sub>		N-Ch	-	30	60	
Body Diode Reverse Recovery Time			P-Ch	-	42	85	ns
Pady Diada Payaraa Passyary Charry	Q <sub>rr</sub>	N-Channel	N-Ch	-	27	55	r.C
Body Diode Reverse Recovery Charge		$I_F = 3.6 \text{ A}, \text{ dI/dt} = 100 \text{ A/}\mu\text{s}, T_J = 25 \text{ °C}$	P-Ch	=.	93	190	nC
Reverse Recovery Fall Time	t <sub>a</sub>	P-Channel	N-Ch	-	19	-	
Heverse Hecovery Fall Tillle		$I_F = -4 \text{ A}, \text{ dI/dt} = -100 \text{ A/}\mu\text{s}, T_J = 25 °\text{C}$	P-Ch	-	36	-	ns
Reverse Recovery Rise Time	t <sub>b</sub>		N-Ch	-	11	-	110
Tiovordo Ficoovery Filide Tillife			P-Ch	-	6	-	

#### Notes

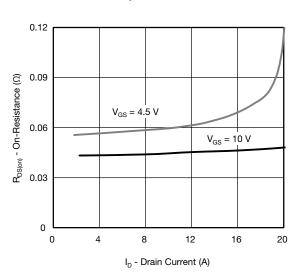
- a. Guaranteed by design, not subject to production testing.
- b. Pulse test; pulse width  $\leq$  300 µs, duty cycle  $\leq$  2 %.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

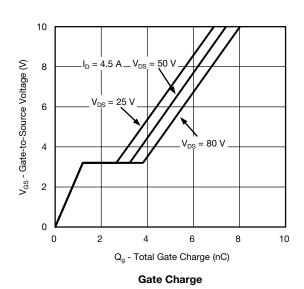


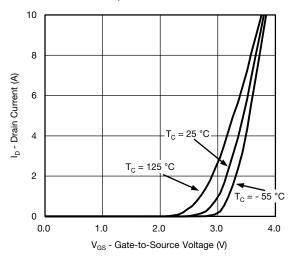


#### **Output Characteristics**

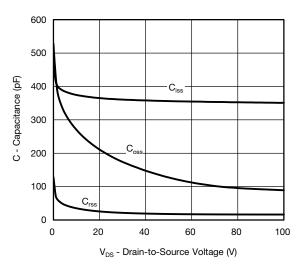


#### On-Resistance vs. Drain Current and Gate Voltage

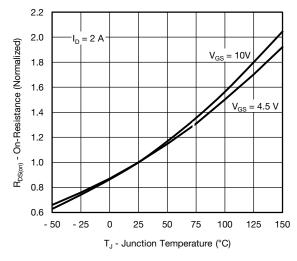




#### **Transfer Characteristics**

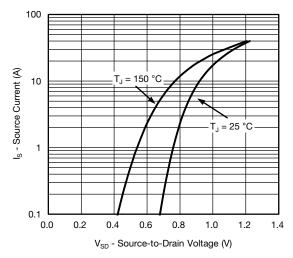


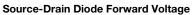
#### Capacitance

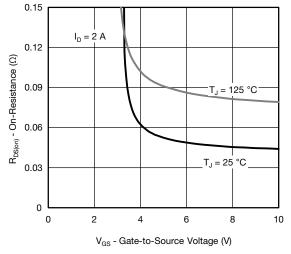


On-Resistance vs. Junction Temperature

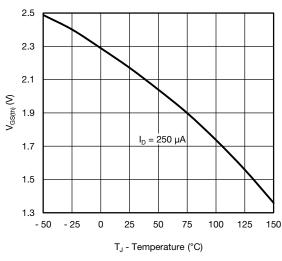




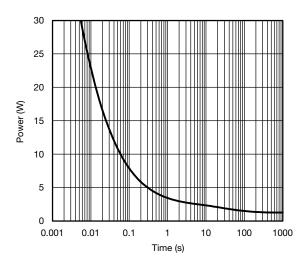




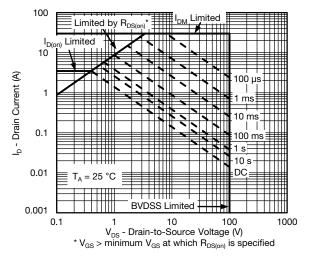
On-Resistance vs. Gate-to-Source Voltage



**Threshold Voltage** 

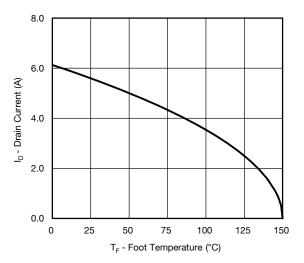


Single Pulse Power, Junction-to-Ambient

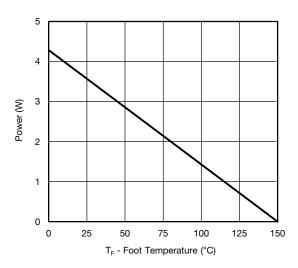


Safe Operating Area, Junction-to-Ambient





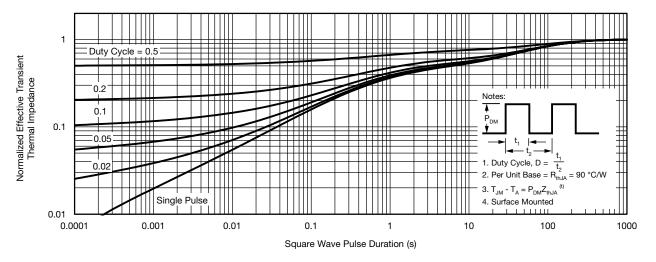
#### **Current Derating\***



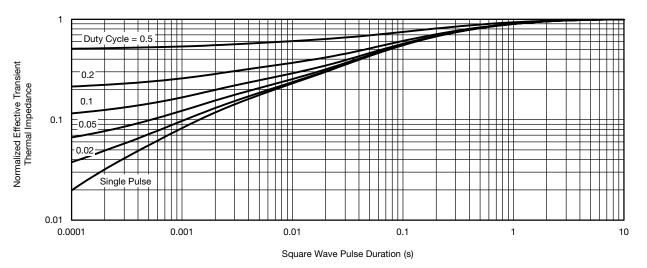
Power Derating, Junction-to-Foot

<sup>\*</sup> The power dissipation  $P_D$  is based on  $T_{J(max.)} = 150$  °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.



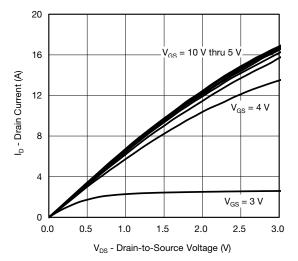


#### Normalized Thermal Transient Impedance, Junction-to-Ambient

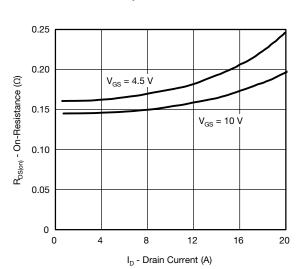


Normalized Thermal Transient Impedance, Junction-to-Foot

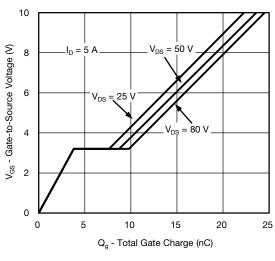




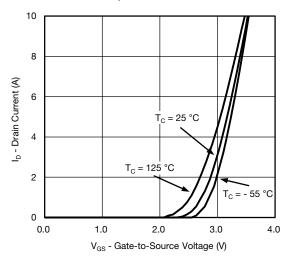
#### **Output Characteristics**



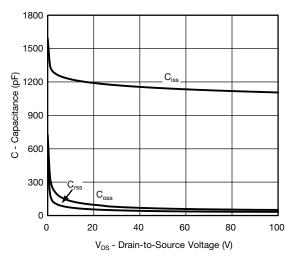
## On-Resistance vs. Drain Current and Gate Voltage



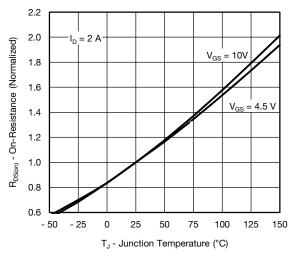
#### **Gate Charge**



#### **Transfer Characteristics**

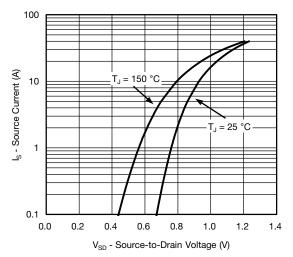


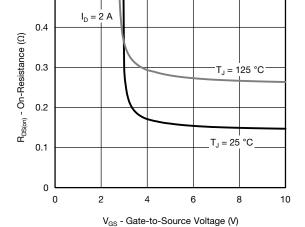
#### Capacitance



On-Resistance vs. Junction Temperature

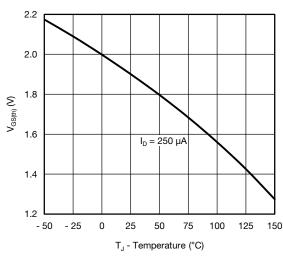


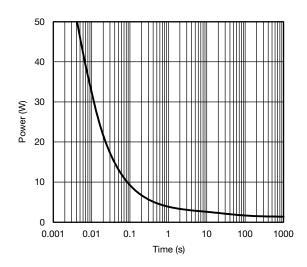




Source-Drain Diode Forward Voltage

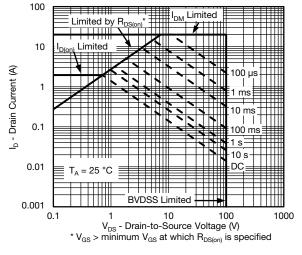
On-Resistance vs. Gate-to-Source Voltage



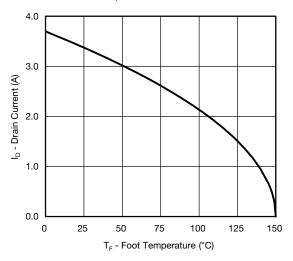


**Threshold Voltage** 

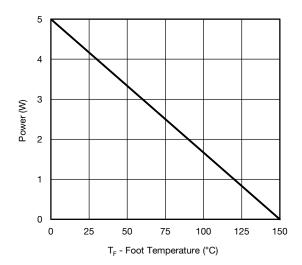
Single Pulse Power, Junction-to-Ambient



Safe Operating Area, Junction-to-Ambient



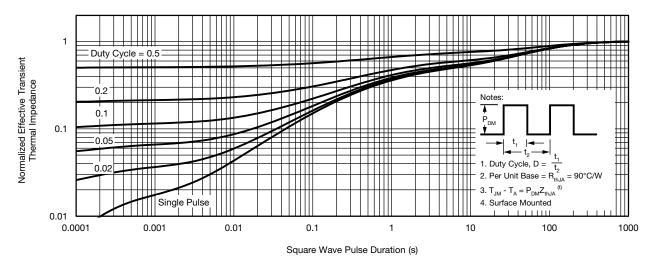
#### **Current Derating\***



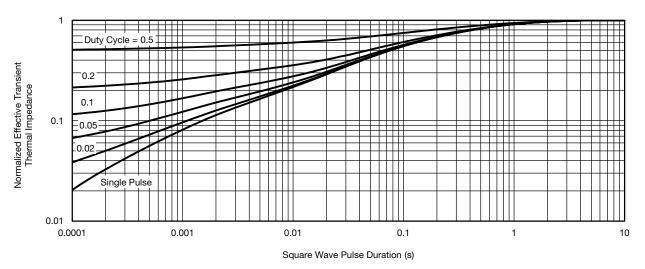
Power Derating, Junction-to-Foot

<sup>\*</sup> The power dissipation PD is based on TJ(max.) = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.





#### Normalized Thermal Transient Impedance, Junction-to-Ambien



Normalized Thermal Transient Impedance, Junction-to-Foot

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SOIC (NARROW): 8-LEAD JEDEC Part Number: MS-012







	MILLIM	IETERS	INCHES			TERS INCHES		
DIM	Min	Max	Min	Max				
Α	1.35	1.75	0.053	0.069				
A <sub>1</sub>	0.10	0.20	0.004	0.008				
В	0.35	0.51	0.014	0.020				
С	0.19	0.25	0.0075	0.010				
D	4.80	5.00	0.189	0.196				
Е	3.80	4.00	0.150	0.157				
е	1.27	BSC	0.050 BSC					
Н	5.80	6.20	0.228	0.244				
h	0.25	0.50	0.010	0.020				
L	0.50	0.93	0.020	0.037				
q	0°	8°	0°	8°				
S	0.44	0.64	0.018	0.026				
ECN: C-06527-Rev. I. 11-Sep-06								

DWG: 5498

Document Number: 71192 www.vishay.com 11-Sep-06



### **RECOMMENDED MINIMUM PADS FOR SO-8**



Recommended Minimum Pads Dimensions in Inches/(mm)

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